

## **AO4468**

# N-Channel Enhancement Mode Field Effect Transistor

## **General Description**

The AO4468 uses advanced trench technology to provide excellent R<sub>DS(ON)</sub> and low gate charge. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance. Standard Product AO4468 is Pb-free (meets ROHS & Sony 259 specifications). AO4468L is a Green Product ordering option. AO4468 and AO4468L are electrically identical.

### **Features**

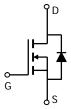
 $V_{DS}(V) = 30V$ 

 $I_D = 11.6A$  (V<sub>GS</sub> = 10V)

 $R_{DS(ON)}$  < 14m $\Omega$  ( $V_{GS}$  = 10V)

 $R_{DS(ON)} < 22m\Omega$  (V<sub>GS</sub> = 4.5V)





Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted								
Parameter Drain-Source Voltage Gate-Source Voltage		Symbol	Maximum	Units V				
		$V_{DS}$	30					
		$V_{GS}$	±20	V				
Continuous Drain	T <sub>A</sub> =25°C		11.6					
Current <sup>A</sup>	T <sub>A</sub> =70°C	I <sub>D</sub>	9.2	Α				
Pulsed Drain Current B		I <sub>DM</sub>	50	7				
	T <sub>A</sub> =25°C	В	3.1	10/				
Power Dissipation	T <sub>A</sub> =70°C	P <sub>D</sub>	2	W				
Junction and Storage Temperature Range		$T_{J}, T_{STG}$	-55 to 150	°C				

Thermal Characteristics									
Parameter	Symbol	Тур	Max	Units					
Maximum Junction-to-Ambient A	t ≤ 10s	$ R_{\theta JA}$	31	40	°C/W				
Maximum Junction-to-Ambient A	Steady-State	Γ <sub>θ</sub> JA	59	75	°C/W				
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	16	24	°C/W				



### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter Conditions		Min	Тур	Max	Units				
STATIC PARAMETERS										
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V				
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V		0.003	1	μА				
		T <sub>J</sub> =55°C			5	μΑ				
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V			±100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=10mA$	1.5	2	3	V				
$I_{D(ON)}$	On state drain current	$V_{GS}$ =4.5V, $V_{DS}$ =5V				Α				
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =11.6A		11	14	mΩ				
		T <sub>J</sub> =125°C		17	21	11152				
		$V_{GS}$ =4.5V, $I_D$ =10A		17.4	22	mΩ				
g <sub>FS</sub>	Forward Transconductance	$V_{DS}=5V, I_{D}=11.6A$		19		S				
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V		0.73	1	V				
Is	Maximum Body-Diode Continuous Current				4.5	Α				
DYNAMIC	PARAMETERS									
C <sub>iss</sub>	Input Capacitance			955	1200	pF				
Coss	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =15V, f=1MHz		145		pF				
$C_{rss}$	Reverse Transfer Capacitance			112		pF				
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		0.5	0.85	Ω				
SWITCHII	NG PARAMETERS									
Q <sub>g</sub> (10V)	Total Gate Charge			17	24	nC				
Q <sub>g</sub> (4.5V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =11.6A		9	12	nC				
$\overline{Q_gs}$	Gate Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =13V, I <sub>D</sub> =11.0A		3.4		nC				
$Q_{gd}$	Gate Drain Charge			4.7		nC				
t <sub>D(on)</sub>	Turn-On DelayTime			5	6.5	ns				
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_L$ =1.30 $\Omega$ ,		6	7.5	ns				
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$		19	25	ns				
t <sub>f</sub>	Turn-Off Fall Time	] [		4.5	6	ns				
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =11.6A, dI/dt=100A/μs		19	21	ns				
$Q_{rr}$	Body Diode Reverse Recovery Charge	I <sub>F</sub> =11.6A, dI/dt=100A/μs		9	12	nC				

A: The value of R  $_{8JA}$  is measured with the device mounted on 1in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$ =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t  $_{\infty}$  10s thermal resistance rating.

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B: Repetitive rating, pulse width limited by junction temperature.

C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using 80  $\,\mu s$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$ =25°C. The SOA curve provides a single pulse rating. Rev 0 : Apr 2006